

P-Channel Trench Power MOSFET



Lead Free Package and Finish

General Description

The RS30P65D uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as -5V. This device is suitable for use as a wide variety of applications.

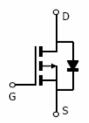
Features

- $V_{DS} = -30V, ID = -65A$ $R_{DS(ON)} < 9m\Omega$ @ $V_{GS} = -10V$ $R_{DS(ON)} < 16m\Omega$ @ $V_{GS} = -5V$
- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package

Application

- DC-DC converter
- Load switch
- Power management

100% UIS TESTED! 100% ΔVds TESTED!



Schematic Diagram



TO-252 top view

Package Marking and Ordering Information

Device Marking	Device	Device Package
RS30P65D	RS30P65D	TO-252

Table 1. Absolute Maximum Ratings (T_A=25℃)

Symbol	Parameter	Value	Unit
V _{DS}	Drain-Source Voltage (Vgs=0V)	-30	V
Vgs	Gate-Source Voltage (V _{DS=} 0V)	±25	V
1	Drain Current-Continuous(Tc=25°C)	-65	А
I _D	Drain Current-Continuous(Tc=100°C)	-45	Α
I _{DM (pluse)}	Drain Current-Continuous@ Current-Pulsed (Note 1)	-260	А
E _{AS}	Avalanche energy (Note 2)	500	mJ
D	Maximum Power Dissipation(Tc=25°C)	83	W
P_{D}	Maximum Power Dissipation(Tc=100℃)	41	W
T_J, T_{STG}	Operating Junction and Storage Temperature Range	-55 To 175	$^{\circ}$ C

Table 2. Thermal Characteristic

Syı	mbol	Parameter	Тур	Max	Unit
R	S enc	Thermal Resistance,Junction-to-Case		1.8	°CW



Table 3. Electrical Characteristics (TA=25°C unless otherwise noted)

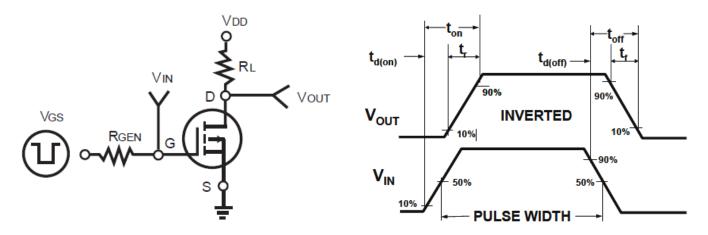
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off Sta	tes					
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V I _D =-250μA	-30			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-30V,V _{GS} =0V			-1	μΑ
I _{GSS}	Gate-Body Leakage Current	V _{GS} =±25V,V _{DS} =0V			±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS},I_{D}=-250\mu A$	-1	-1.8	-3	V
g FS	Forward Transconductance	V _{DS} =-5V,I _D =-10A	20	28		S
D	Dunin Course On Chata Basistanas	V _{GS} =-10V, I _D =-20A		7.1	9	mΩ
R _{DS(ON)}	Drain-Source On-State Resistance	V _{GS} =-5V, I _D =-15A		10	16	mΩ
Dynamic C	Characteristics					
Ciss	Input Capacitance			3570		pF
Coss	Output Capacitance	V _{DS} =-15V,V _{GS} =0V, f=1.0MHz		435		pF
C _{rss}	Reverse Transfer Capacitance			175		pF
Switching	Times			•		
t _{d(on)}	Turn-on Delay Time			16		nS
t _r	Turn-on Rise Time	V_{DD} =-15V, I_{D} =-1A, R_{L} =15 Ω		14		nS
t _{d(off)}	Turn-Off Delay Time	V _{GS} =-10V,R _G =2.5Ω		50		nS
t _f	Turn-Off Fall Time			22		nS
Qg	Total Gate Charge			58		nC
Q_{gs}	Gate-Source Charge	Vgs=-10V, Vps=-15V, Ip=-10A		9		nC
Q_{gd}	Gate-Drain Charge			14		nC
Source-Dra	ain Diode Characteristics		•	•		,
I _{SD}	Source-Drain Current(Body Diode)				-50	А
V _{SD}	Forward on Voltage	Vgs=0V,Is=-10A			-1.2	V

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

Notes 2.Eas condition: T_J=25 $^{\circ}\text{C}$,Vdd=30V,V_G=-10V, RG=25 Ω



Switch Time Test Circuit and Switching Waveforms:



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (Curves)

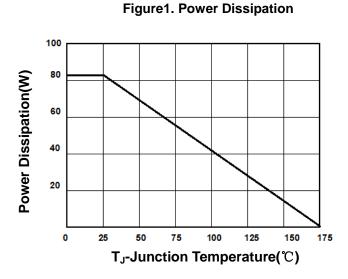


Figure3. Output Characteristics

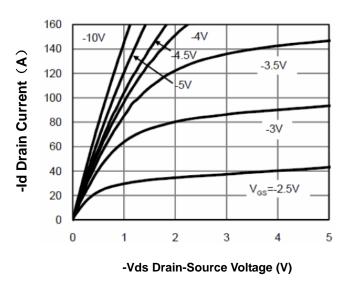


Figure 2. Drain Current

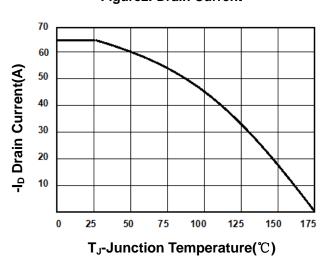


Figure 4. Transfer Characteristics

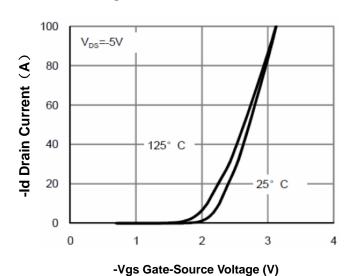




Figure 5. Capacitance

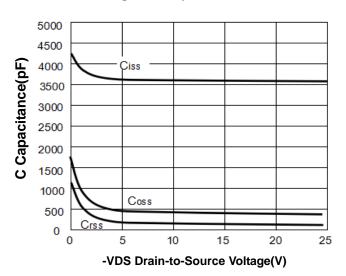


Figure 6. R_{DS(ON)} vs Junction Temperature

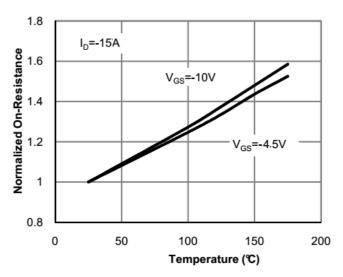


Figure 7. Max BV_{DSS} vs Junction Temperature

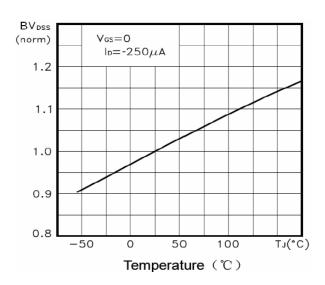


Figure 8. V_{GS(th)} vs Junction Temperature

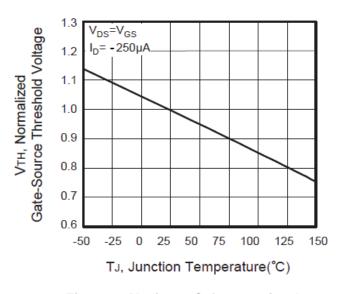


Figure9. Gate Charge Waveforms

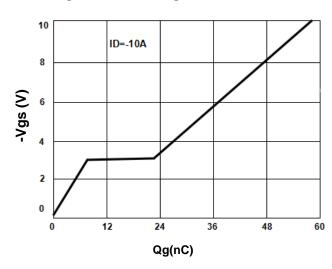
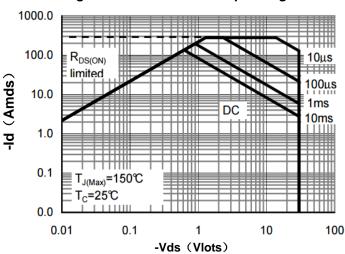


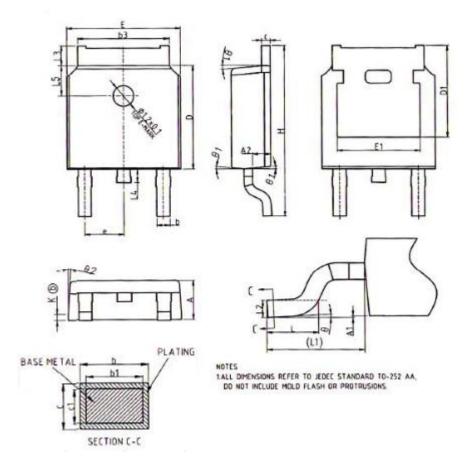
Figure 10. Maximum Safe Operating Area



10 In descending order Z_{euc} Normalized Transient Thermal Resistance D=0.5, 0.3, 0.1, 0.05, 0.02, 0.01, single pulse $T_{J,PK}=T_C+P_{DM}.Z_{\theta JC}.R_{\theta JC}$ 1 P_D 0.1 Single Pulse 0.01 0.00001 0.0001 0.001 0.01 0.1 1 10 Pulse Width (s)

Figure 11. Normalized Maximum Transient Thermal Impedance

TO-252 Package Information



	nn			
SYMBOL	MIN	NOM	MAX	
٨	2.20	2.30	2.38	
A1	0.00	-	0.10	
A2.	0.97	1.07	1.17	
b	0.72	0.78	0, 85	
bl	0.71	0,76	0.81	
b3	5. 23	5, 33	5.46	
c	0.47	0.53	0.58	
cl	0.46	0.51	0.56	
D	6,00	6.10	6,20	
DI		5. 30REF		
E	6.50	6.60	6.70	
E1	4.70	4.83	4.92	
e	- 77	2. 286BSC	110000	
н	9, 90	10, 10	10.30	
L	1, 40	1.50	1,70	
LI		2, 90REF		
1.2		0. 51BSC		
L3	0.90	-	1. 25	
1.4	0.60	0.80	1,00	
L5	1,70	1.80	1,90	
0	0,	+	8*	
0 1	5*	7*	9.	
0.2	5*	7*	9*	
K		0. 40REF		



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